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ICS 31.070
CCS L15

SJ

INDUSTRY STANDARD OF THE PEOPLE'S REPUBLIC OF CHINA

SJ 21265-2018

Technical requirements for MEMS gyroscope parameter calibration process

MEMS 陀螺仪参数标定工艺技术要求

(English Translation)

Implemented on: May 1, 2018

Issued by: Ministry of Industry and Information Technology

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1 Foreword

SJ 21265-2018 is issued by Ministry of Industry and Information Technology.

The SJ prefix, without a suffix, marks a mandatory standard: within its scope, compliance is required.

The document runs to 8 pages in English translation.

2 Scope Preview

SJ 21265-2018 falls under ICS 31.070, in the field of electronics.

This catalogue holds 133 other SJ standards in that field.

In this catalogue, SJ standards carry edition years from 1965 to 2021.

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3 About this standard

Sector: Electronics Industry Standard

Issued by: Ministry of Industry and Information Technology

English translation: about 8 pages (approximate)

Chinese original: about 12,123 characters

4 Related standards

Standards on related subjects:

GB/Z 40842-2021 - General technical requirenments for electrolarynx

SJ/T 10410-2016 - Permanent ferrite materials

SJ/T 11633-2016 - Supporting high-voltage bus capacitors selective specifications for electric vehicle motor controller

SJ 21263-2018 - Technical requirements for calibration of MEMS acceleration sensor parameters

SJ 21262-2018 - Technical requirements for on-chip testing of MEMS inertial device chips

SJ 21261-2018 - MEMS inertial device structural design requirements

5 Classification and status

International classification (ICS): 31.070

Chinese Standard Classification (CCS): L 15

Prefix SJ: mandatory standard.

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